

Notice of References Cited

Application/Control No.

10/772,120

Applicant(s)/Patent Under
Reexamination
CHUI, CLARENCE

Examiner

David L. Lewis

Art Unit

2629

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,196,837	03-2007	Sampsell et al.	345/85
*	B	US-2006/0256059	11-2006	Stumbo et al.	345/092
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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